

MT3208

N-Channel Power MOSFET

80V, 85A, 6.8mΩ

Features

- Max $R_{DS(on)} = 6.8m\Omega$ at $V_{GS} = 10V$, $I_D = 35A$
- Fast Switching Speed
- Low Gate Charge
- High Performance Trench Technology for Extr emely Low $R_{DS(on)}$
- High Power and Current Handling Capability
- RoHS Compliant

General Description

This N-Channel MOSFET is produced using MOS-TECH Semiconductor's advanced PowerTrench process that has been especially tailored to minimize the on-state resistance and yet maintain superior switching performance.

Applications

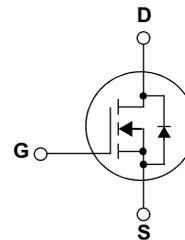
- DC-DC primary bridge
- DC-DC Synchronous rectification
- Hot swap



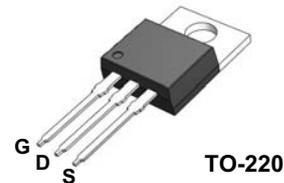
MT Semiconductor®

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Simplified Schematic



MARKING DIAGRAM & PIN ASSIGNMENT



MOSFET Maximum Ratings $T_C = 25^\circ C$ unless otherwise noted

Symbol	Parameter	MT3208	Units
V_{DSS}	Drain-Source Voltage	80	V
I_D	Drain Current - Continuous ($T_C = 25^\circ C$) - Continuous ($T_C = 100^\circ C$)	85	A
		70	A
I_{DM}	Drain Current - Pulsed (Note 1)	300	A
V_{GSS}	Gate-Source Voltage	± 20	V
E_{AS}	Single Pulsed Avalanche Energy (Note 2)	1738	mJ
I_{AR}	Avalanche Current (Note 1)	75	A
E_{AR}	Repetitive Avalanche Energy (Note 1)	13.7	mJ
dv/dt	Peak Diode Recovery dv/dt (Note 3)	4.5	V/ns
P_D	Power Dissipation ($T_C = 25^\circ C$)	137	W
	- Derate above $25^\circ C$	1.09	W/ $^\circ C$
T_J, T_{STG}	Operating and Storage Temperature Range	-55 to +150	$^\circ C$
T_L	Maximum lead temperature for soldering purposes, 1/8" from case for 5 seconds	300	$^\circ C$

Package Marking and Ordering Information

Device Marking	Device	Package	Reel Size	Tape Width	Quantity
MT3208	MT3208	TO-220	-		50

Electrical Characteristics T_C = 25°C unless otherwise noted

Symbol	Parameter	Test Conditions	Min	Typ	Max	Units	
Off Characteristics							
B _V DSS	Drain-Source Breakdown Voltage	V _{GS} = 0 V, I _D = 250μA	80			V	
$\frac{\Delta B_{V_{DSS}}}{\Delta T_J}$	Breakdown Voltage Temperature Coefficient	I _D = 250 μA, Referenced to 25°C	--	0.6	--	V/°C	
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} = 80V, V _{GS} = 0 V	--	--	1	μA	
		V _{DS} = 60 V, T _C = 125°C	--	--	10	μA	
I _{GSSF}	Gate-Body Leakage Current, Forward	V _{GS} = 20 V, V _{DS} = 0 V	--	--	100	nA	
I _{GSSR}	Gate-Body Leakage Current, Reverse	V _{GS} = -20 V, V _{DS} = 0 V	--	--	-100	nA	
On Characteristics							
V _{GS(th)}	Gate Threshold Voltage	V _{DS} = V _{GS} , I _D = 250 μA	2.0	--	4.0	V	
R _{DS(on)}	Static Drain-Source On-Resistance	V _{GS} = 10 V, I _D = 50 A	--	6.8	9	mΩ	
g _{FS}	Forward Transconductance	V _{DS} = 40 V, I _D = 50A (Note 4)	--	58	--	S	
Dynamic Characteristics							
C _{iSS}	Input Capacitance	V _{DS} = 25 V, V _{GS} = 0 V, f = 1.0 MHz	--	3437	4468	pF	
C _{oSS}	Output Capacitance		--	738	959	pF	
C _{rSS}	Reverse Transfer Capacitance		--	86	129	pF	
Switching Characteristics							
t _{d(on)}	Turn-On Delay Time	V _{DD} = 37.5 V, I _D = 85A, R _G = 25 Ω	--	43	95	ns	
t _r	Turn-On Rise Time		--	212	434	ns	
t _{d(off)}	Turn-Off Delay Time		(Note 4, 5)	--	273	556	ns
t _f	Turn-Off Fall Time		--	147	303	ns	
Q _g	Total Gate Charge	V _{DS} = 60 V, I _D = 85A, V _{GS} = 10 V	--	80	104	nC	
Q _{gs}	Gate-Source Charge		--	20	--	nC	
Q _{gd}	Gate-Drain Charge		(Note 4, 5)	--	24	--	nC
Drain-Source Diode Characteristics and Maximum Ratings							
I _S	Maximum Continuous Drain-Source Diode Forward Current		--	--	85	A	
I _{SM}	Maximum Pulsed Drain-Source Diode Forward Current		--	--	300	A	
V _{SD}	Drain-Source Diode Forward Voltage	V _{GS} = 0 V, I _S = 85 A	--	--	1.3	V	
t _{rr}	Reverse Recovery Time	V _{GS} = 0 V, I _S = 85 A, dI _F / dt = 100 A/μs	--	62	--	ns	
Q _{rr}	Reverse Recovery Charge		(Note 4)	--	380	--	nC

NOTES:

1. Repetitive Rating : Pulse width limited by maximum junction temperature
2. L = 206μH, I_{AS} = 75A, V_{DD} = 50V, R_G = 25 Ω, Starting T_J = 25°C
3. I_{SD} ≤ 100A, di/dt ≤ 200A/μs, V_{DD} ≤ BV_{DSS}, Starting T_J = 25°C
4. Pulse Test : Pulse width ≤ 300μs, Duty cycle ≤ 2%
5. Essentially independent of operating temperature

Typical Performance Characteristics

Figure 1. On-Region Characteristics

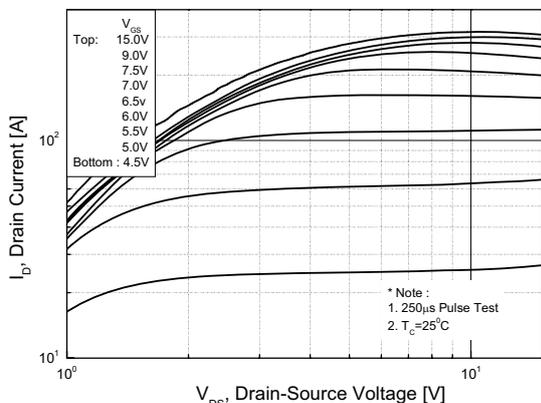


Figure 2. Transfer Characteristics

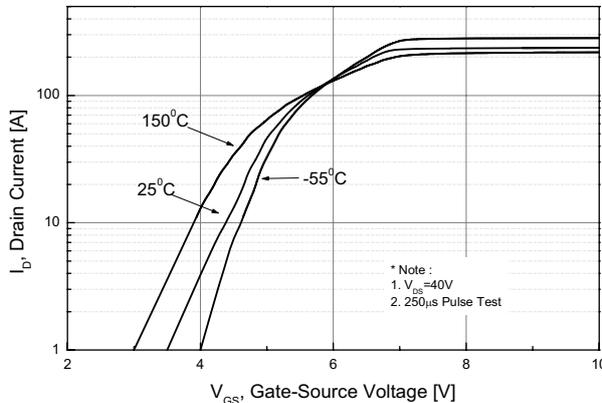


Figure 3. On-Resistance Variation vs. Drain Current and Gate Voltage

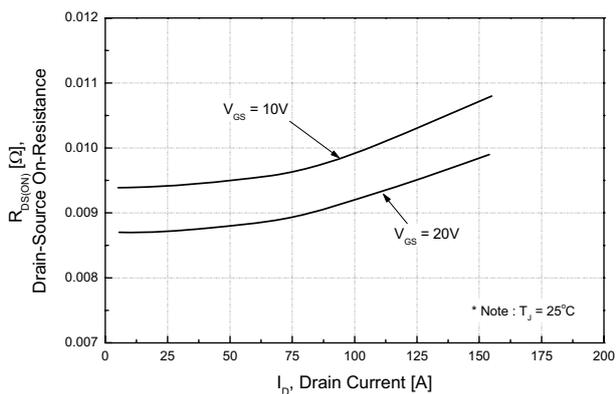


Figure 4. Body Diode Forward Voltage Variation vs. Source Current and Temperature

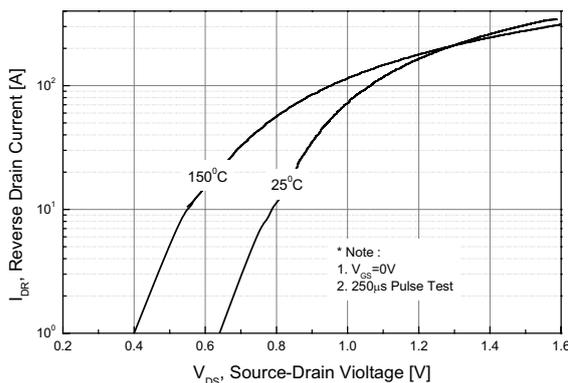


Figure 5. Capacitance Characteristics

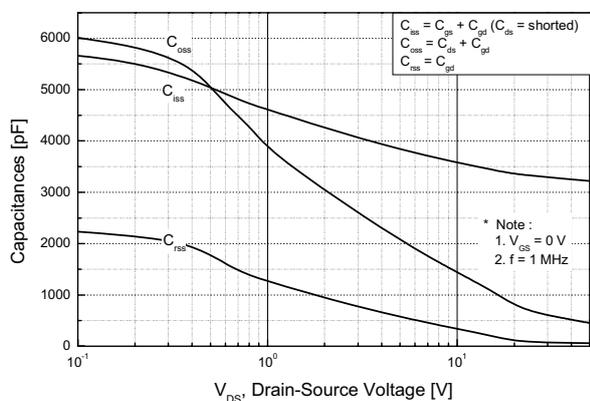
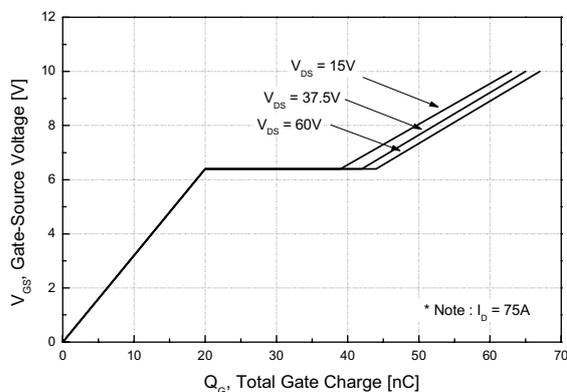


Figure 6. Gate Charge Characteristics



Typical Performance Characteristics (Continued)

Figure 7. Breakdown Voltage Variation vs. Temperature

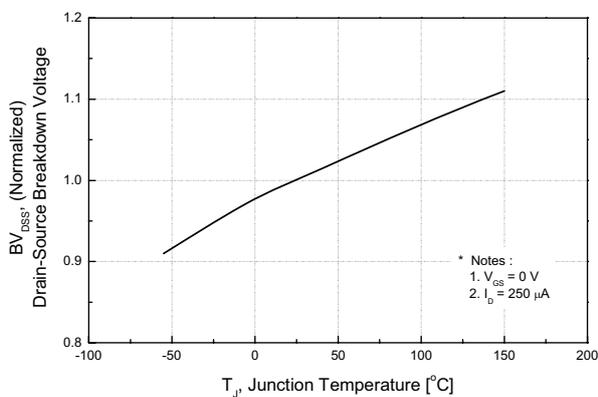


Figure 8. On-Resistance Variation vs. Temperature

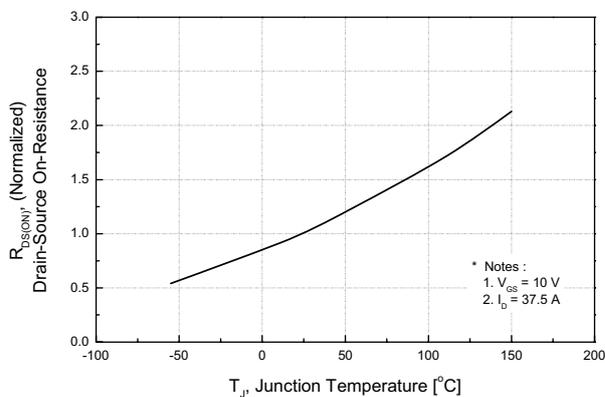


Figure 9. Maximum Safe Operating Area

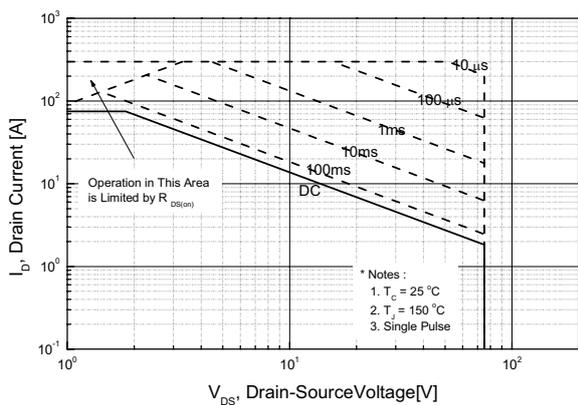


Figure 10. Maximum Drain Current vs. Case Temperature

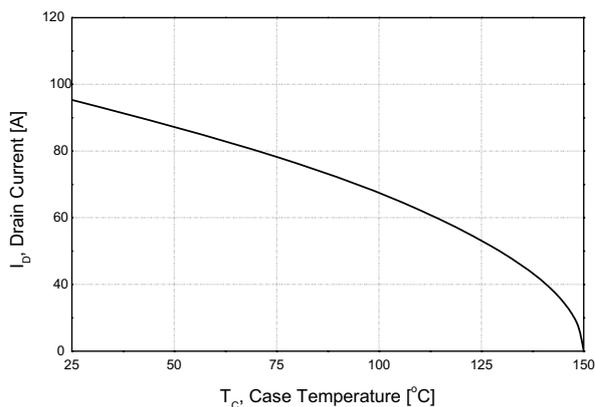
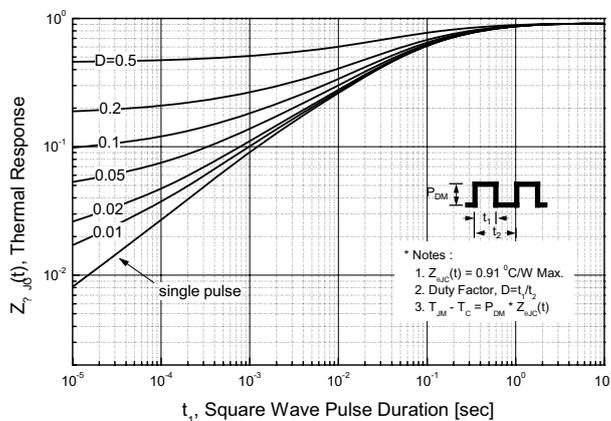
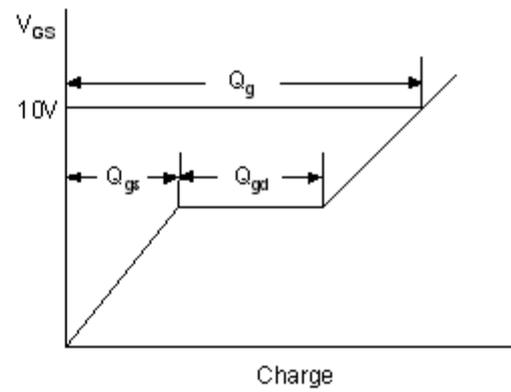
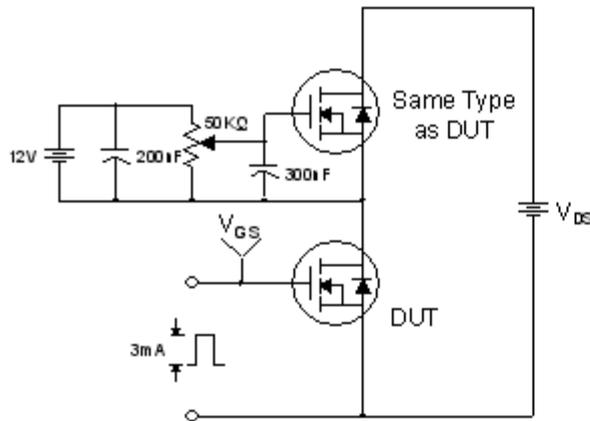


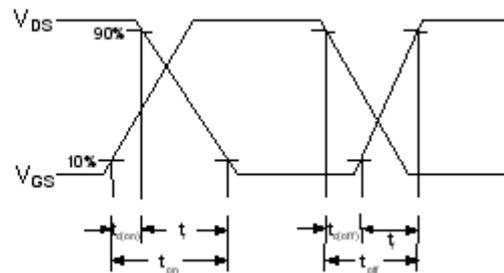
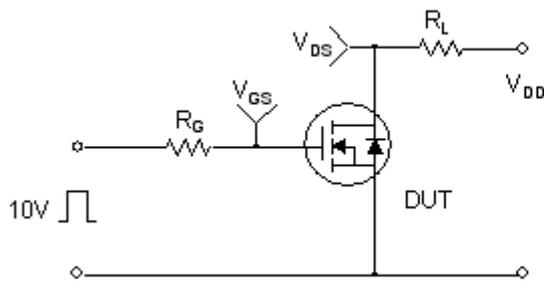
Figure 11. Transient Thermal Response Curve



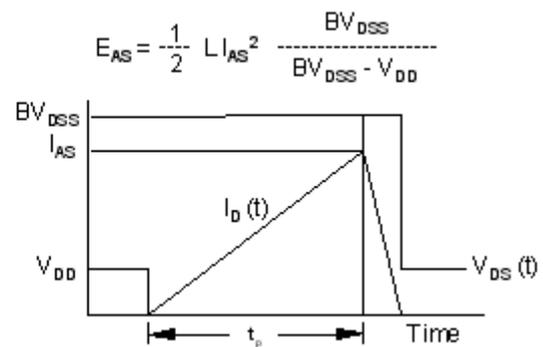
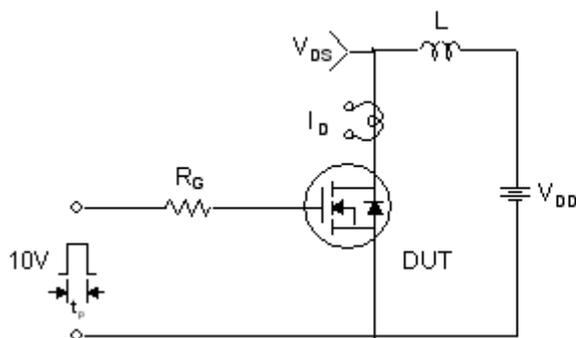
Gate Charge Test Circuit & Waveform



Resistive Switching Test Circuit & Waveforms



Unclamped Inductive Switching Test Circuit & Waveforms



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